Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | AGIN ET AL. | Examiner | Art Unit | Feben M. Haile | 2663 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	Α	US-6,330,232 B1	12-2001	Fapojuwo, Abraham Olatunji	370/342	
	В	US-6,738,624 B1	05-2004	Aksentijevic et al.	455/452.1	
	С	US-6,278,882 B1	08-2001	Choi, Yong Su	455/453	
	D	US-			·	
	Е	US-				
	F	US-				
	G	US-				
	Н	US-				
	-	US-				
	J	US-				
	К	US-			·	
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р		_			
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	>	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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